# **IGBT**

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop (FS) Trench construction, and provides superior performance in demanding switching applications, offering both low on-state voltage and minimal switching loss. The IGBT is well suited for resonant or soft switching applications. Incorporated into the device is a rugged co-packaged free wheeling diode with a low forward voltage.

#### **Features**

- Low Saturation Voltage using Trench with Field Stop Technology
- Low Switching Loss Reduces System Power Dissipation
- Optimized for Low Case Temperature in IH Cooker Application
- Low Gate Charge
- These are Pb-Free Devices

### **Typical Applications**

- Inductive Heating
- Consumer Appliances
- Soft Switching

#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Value	Unit
$V_{CES}$	1200	V
I <sub>C</sub>	80 40	A
I <sub>CM</sub>	320	Α
I <sub>F</sub>	80 40	A
I <sub>FM</sub>	320	Α
$V_{GE}$	±20	V
P <sub>D</sub>	260 104	W
TJ	–55 to +150	°C
T <sub>stg</sub>	-55 to +150	°C
T <sub>SLD</sub>	260	°C
	V <sub>CES</sub> I <sub>C</sub> I <sub>CM</sub> I <sub>F</sub> I <sub>FM</sub> V <sub>GE</sub> P <sub>D</sub> T <sub>J</sub> T <sub>stg</sub>	V <sub>CES</sub> 1200       I <sub>C</sub> 80 40       I <sub>CM</sub> 320       I <sub>F</sub> 80 40       I <sub>FM</sub> 320       V <sub>GE</sub> ±20       P <sub>D</sub> 260 104       T <sub>J</sub> -55 to +150       T <sub>stg</sub> -55 to +150

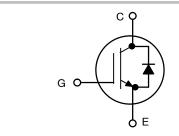
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

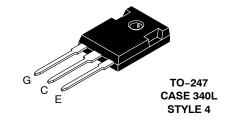


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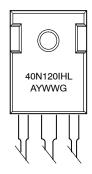
http://onsemi.com

40 A, 1200 V V<sub>CEsat</sub> = 1.90 V E<sub>off</sub> = 1.40 mJ





## **MARKING DIAGRAM**



A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

#### **ORDERING INFORMATION**

Device	Package	Shipping
NGTB40N120IHLWG	TO-247 (Pb-Free)	30 Units / Rail

## THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{ heta JC}$	0.48	°C/W
Thermal resistance junction-to-case, for Diode	$R_{ heta JC}$	1.5	°C/W
Thermal resistance junction-to-ambient	$R_{ heta JA}$	40	°C/W

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
STATIC CHARACTERISTIC	•			•		•
Collector-emitter breakdown voltage, gate-emitter short-circuited	$V_{GE} = 0 \text{ V}, I_{C} = 500 \mu\text{A}$	V <sub>(BR)CES</sub>	1200	_	-	V
Collector-emitter saturation voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 40 A V <sub>GE</sub> = 15 V, I <sub>C</sub> = 40 A, T <sub>J</sub> = 150°C	V <sub>CEsat</sub>	- -	1.90 2.1	2.35	V
Gate-emitter threshold voltage	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 400 μA	V <sub>GE(th)</sub>	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate- emitter short-circuited	$V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}$ $V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}, T_{J=150^{\circ}C}$	I <sub>CES</sub>	- -	_ _	0.5 2.0	mA
Gate leakage current, collector-emitter short-circuited	V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0 V	I <sub>GES</sub>	-	_	200	nA
DYNAMIC CHARACTERISTIC	•					•
Input capacitance		C <sub>ies</sub>	-	10400	_	pF
Output capacitance	V <sub>CE</sub> = 20 V, V <sub>GE</sub> = 0 V, f = 1 MHz	C <sub>oes</sub>	-	245	-	
Reverse transfer capacitance	1	C <sub>res</sub>	-	185	=	
Gate charge total		$Q_g$		420		nC
Gate to emitter charge	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 40 A, V <sub>GE</sub> = 15 V	Q <sub>ge</sub>		95		
Gate to collector charge	]	Q <sub>gc</sub>		178		
SWITCHING CHARACTERISTIC, INDUC	TIVE LOAD					
Turn-off delay time	T <sub>J</sub> = 25°C	t <sub>d(off)</sub>		360		ns
Fall time	$V_{CC} = 600 \text{ V}, I_{C} = 40 \text{ A}$ $R_{g} = 10 \Omega$	t <sub>f</sub>		130		
Turn-off switching loss	V <sub>GE</sub> = 0 V/ 15V	E <sub>off</sub>		1.40		mJ
Turn-off delay time	T <sub>J</sub> = 125°C	t <sub>d(off)</sub>		380		ns
Fall time	$V_{CC} = 600 \text{ V, I}_{C} = 40 \text{ A}$ $R_{a} = 10 \Omega$	t <sub>f</sub>		185		
Turn-off switching loss	V <sub>GE</sub> = 0 V/ 15V	E <sub>off</sub>		2.6		mJ
DIODE CHARACTERISTIC						
Forward voltage	V <sub>GE</sub> = 0 V, I <sub>F</sub> = 40 A V <sub>GE</sub> = 0 V, I <sub>F</sub> = 40 A, T <sub>J</sub> = 150°C	V <sub>F</sub>		1.6 1.8	1.8	V

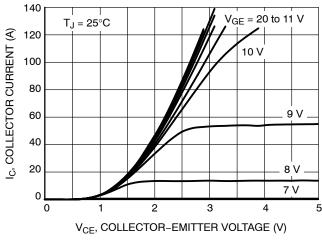


Figure 1. Output Characteristics

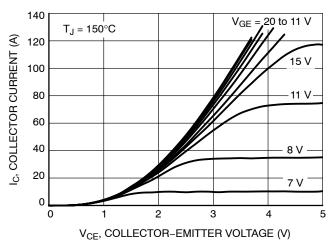


Figure 2. Output Characteristics

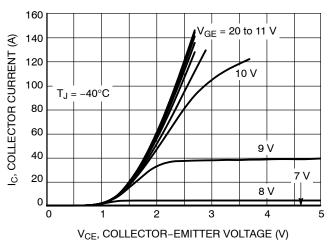
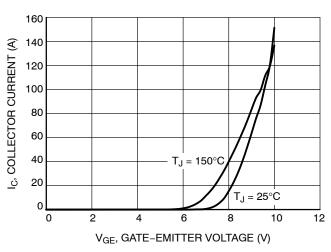


Figure 3. Output Characteristics



**Figure 4. Typical Transfer Characteristics** 

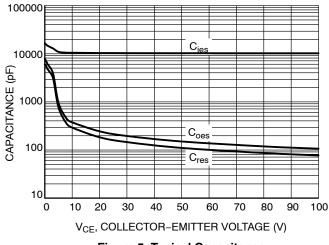


Figure 5. Typical Capacitance

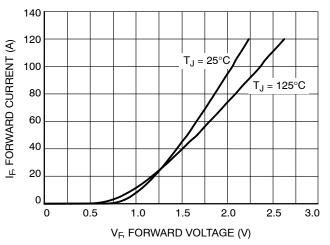
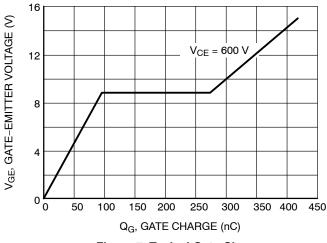


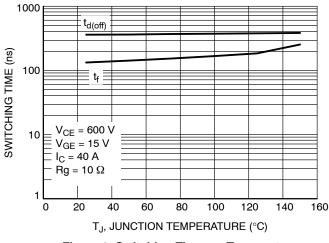
Figure 6. Diode Forward Characteristics



(m) 3.5 V<sub>CE</sub> = 600 V Eoff, TURN-OFF SWITCHING LOSS 3  $V_{GE} = 15 V$  $I_{C} = 40 \text{ A}$ 2.5  $Rg = 10 \Omega$ 2 1.5 0.5 0 0 140 100 120 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 7. Typical Gate Charge

Figure 8. Energy Loss vs. Temperature



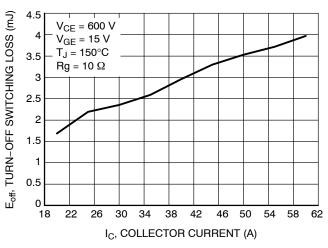
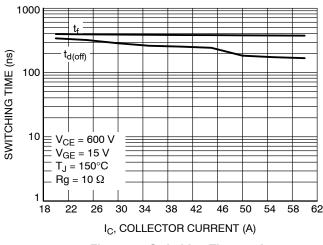


Figure 9. Switching Time vs. Temperature

Figure 10. Energy Loss vs. I<sub>C</sub>



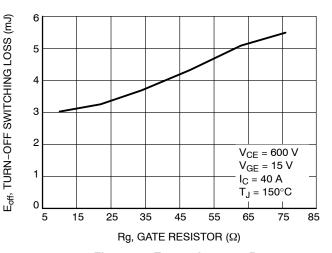


Figure 11. Switching Time vs. I<sub>C</sub>

Figure 12. Energy Loss vs. Rg

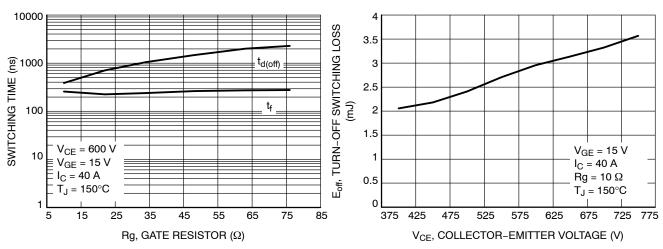


Figure 13. Switching Time vs. Rg

Figure 14. Energy Loss vs. V<sub>CE</sub>

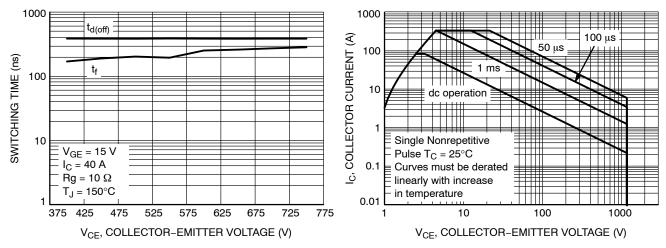


Figure 15. Switching Time vs. V<sub>CE</sub>

Figure 16. Safe Operating Area

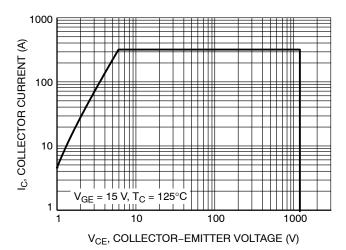


Figure 17. Reverse Bias Safe Operating Area

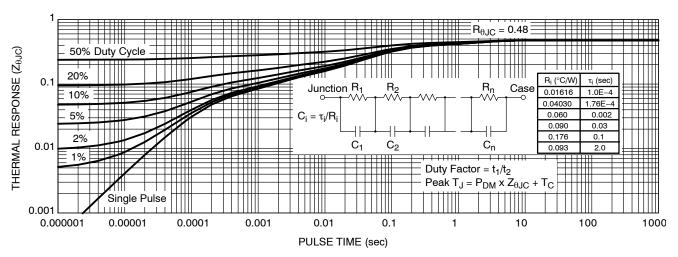


Figure 18. IGBT Transient Thermal Impedance

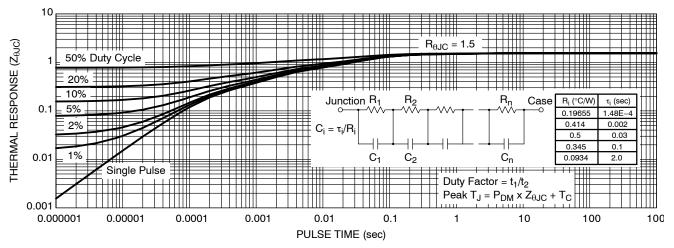


Figure 19. Diode Transient Thermal Impedance

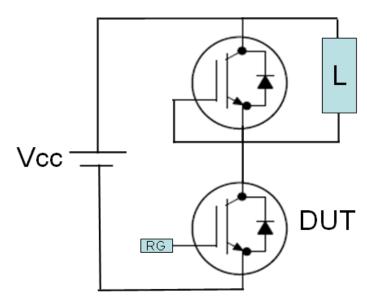


Figure 20. Test Circuit for Switching Characteristics

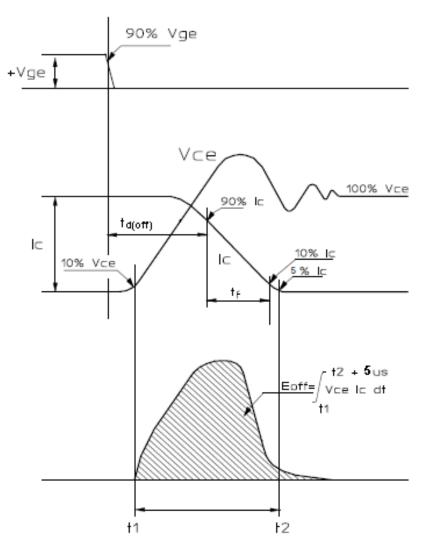
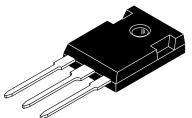


Figure 21. Definition of Turn Off Waveform





TO-247 CASE 340L ISSUE G

**DATE 06 OCT 2021** 

#### NOTES:

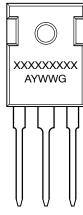
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1982.

	MILLIMETERS		INC	HES
DIM	MIN.	MAX.	MIN.	MAX.
Α	20.32	21.08	0.800	0.830
В	15.75	16.26	0.620	0.640
С	4.70	5.30	0.185	0.209
D	1.00	1.40	0.040	0.055
Ε	1.90	2.60	0.075	0.102
F	1.65	2.13	0.065	0.084
G	5.45 BSC		0.215 BSC	
Н	1.50	2.49	0.059	0.098
J	0.40	0.80	0.016	0.031
К	19.81	20.83	0.780	0.820
L	5.40	6.20	0.212	0.244
N	4.32	5.49	0.170	0.216
Р		4.50		0.177
Q	3.55	3.65	0.140	0.144
U	6.15 BSC		0.242	BSC
W	2.87	3.12	0.113	0.123

2. CONTROLLING DIMENSION: MILLIMETER

	SCALE 1:1	
2X F—	B  A  ØQ  (**)  Ø(0.63 (0.025) (**)  Y  Y   3X D	SEATING PLANE
	♦ 0.25 (0.010)	

## **GENERIC MARKING DIAGRAM\***



STYLE 1: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PIN 1. CATHODE 2. ANODE

3. GATE 4. ANODE

STYLE 5:

STYLE 2: PIN 1. ANODE 2. CATHODE (S) 3. ANODE 2 4. CATHODES (S)

PIN 1. MAIN TERMINAL 1 2. MAIN TERMINAL 2

3. GATE 4. MAIN TERMINAL 2

STYLE 6:

STYLE 3: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR STYLE 4: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR

XXXXX = Specific Device Code = Assembly Location Α

Υ = Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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